

**Notice of References Cited**

Application/Control No.

10/539,400

Applicant(s)/Patent Under  
Reexamination  
FUJIKAWA ET AL.

Examiner

Patricia L. Hailey

Art Unit

1793

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,559,092	05-2003	Dufresne et al.	502/180
*	B	US-5,397,456	03-1995	Dai et al.	208/108
*	C	US-5,928,499	07-1999	Sherwood et al.	208/216PP
*	D	US-5,468,709	11-1995	Yamaguchi et al.	502/210
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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